TOSHIBA Field Effect Transistor Silicon N-Channel MOS Type (U-MOS V-H)

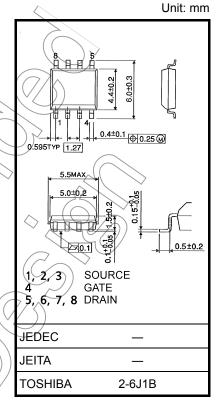
TPC8031-H

High-Efficiency DC/DC Converter Applications Notebook PC Applications Portable Equipment Applications

- Small footprint due to a small and thin package
- High-speed switching
- Small gate charge: QSW = 5.0 nC (typ.)
- Low drain-source ON-resistance: RDS (ON) = $10.1 \text{ m}\Omega$ (typ.)
- High forward transfer admittance: $|Y_{fs}| = 33 S$ (typ.)
- Low leakage current: $I_{DSS} = 10 \mu A (max) (V_{DS} = 30 V)$
- Enhancement mode: $V_{th} = 1.5$ to 2.5 V ($V_{DS} = 10$ V, $I_{D} = 1$ mA)

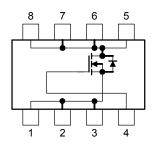
Absolute Maximum Ratings (Ta = 25°C)

Characteristic		Symbol	Rating	Unit
Drain-source voltage		V_{DSS}	30	V
Drain-gate voltage ($R_{GS} = 20 \text{ k}\Omega$)		V _{DGR}	30	V
Gate-source voltage		V _{GSS}	±20	<\\v
Drain current	DC (Note 1)	ID(11	A
Drain current	Pulsed (Note 1)	₽ N	44	,
Drain power dissipation (t = 10 s) (Note 2a)		PD	1.9	\\\
Drain power dissipation (t = 10 s) (Note 2b)		D	1.0	w
Single-pulse avalanche energy (Note 3)		EAS	79	mJ
Avalanche current		IAR	11	Α
Repetitive avalanche energy (Note 2a) (Note 4)		EAR	0.16	mJ
Channel temperature		₹ch	150	°C
Storage temperature range		T _{stg}	-55 to 150	°C



Weight: 0.085 g (typ.)

Circuit Configuration



Note: For Notes 1 to 4, refer to the next page.

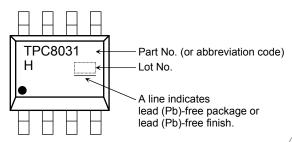
Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings. Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

This transistor is an electrostatic-sensitive device. Handle with care.

Thermal Characteristics

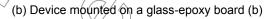
Characteristic	Symbol	Max	Unit
Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2a)	R _{th (ch-a)}	65.8	°C/W
Thermal resistance, channel to ambient $(t = 10 \text{ s})$ (Note 2b)	R _{th (ch-a)}	125	°C/W

Marking (Note 5)



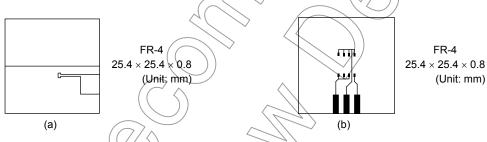
Note 1: The channel temperature should not exceed 150°C during use.

Note 2: (a) Device mounted on a glass-epoxy board (a)



FR-4

(Unit: mm)



Note 3: $V_{DD} = 24 \text{ V}$, $T_{ch} = 25^{\circ}\text{C}$ (initial), L = 0.5 mH, $R_G = 25^{\circ}\Omega$, $I_{AR} = 11 \text{ A}$

Note 4: Repetitive rating: pulse width limited by max channel temperature

Note 5: • on lower left of the marking indicates Pin 1.

* Weekly code: (Three digits)

Week of manufacture (01 for first week of year, continuing up to 52 or 53)

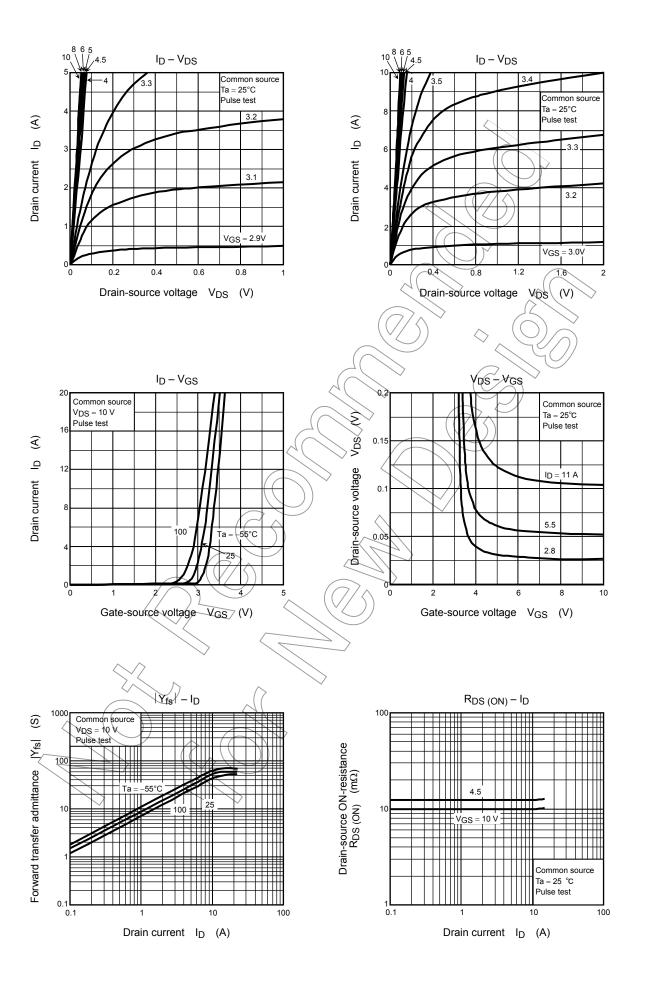
> Year of manufacture (The last digit of a year)

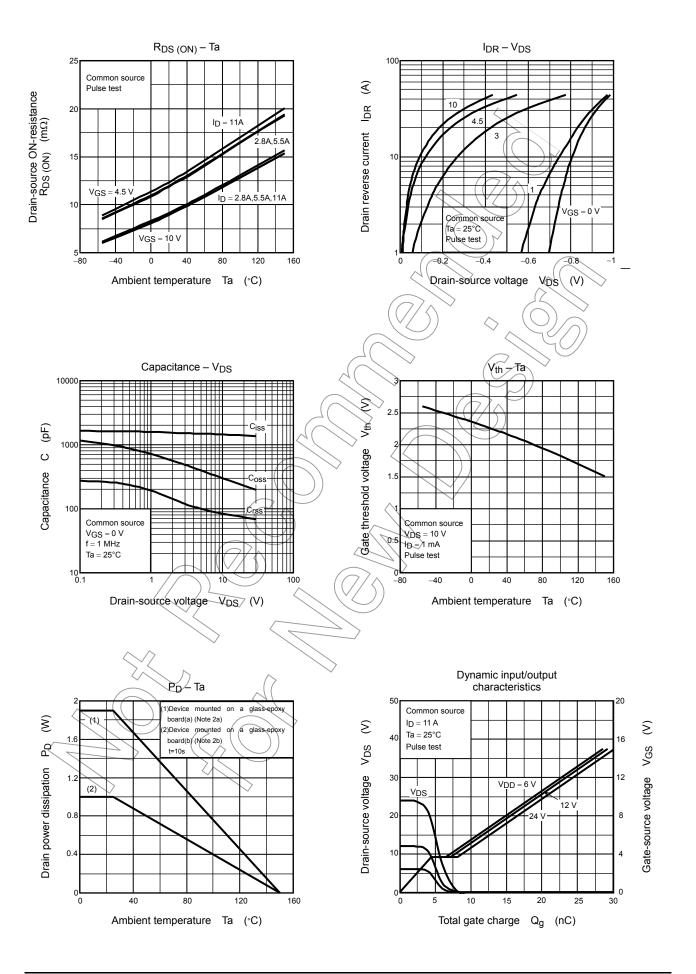
Electrical Characteristics (Ta = 25°C)

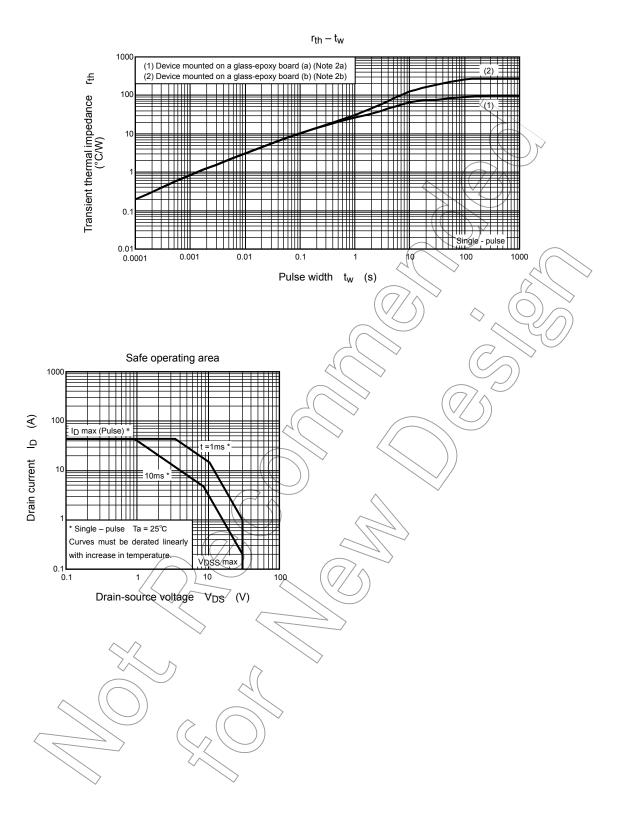
Cha	racteristic	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage curre	ent	I _{GSS}	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$	_	_	±100	nA
Drain cutoff curren	nt	I _{DSS}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}$			10	μΑ
Drain-source breakdown voltage		V (BR) DSS	$I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$	30	_		V
		V (BR) DSX	$I_D = 10 \text{ mA}, V_{GS} = -20 \text{ V}$	15	_		V
Gate threshold vol	tage	V _{th}	V _{DS} = 10 V, I _D = 1 mA	1.5) >_	2.5	V
Drain-source ON-resistance		_	V _{GS} = 4.5 V, I _D = 5.5 A)	12.4	16.1	- mΩ
		R _{DS} (ON)	V _{GS} = 10 V, I _D = 5.5 A	\rightarrow	10.1	13.3	
Forward transfer a	dmittance	Y _{fs}	V _{DS} = 10 V, I _D = 5.5 A	16.5	33		S
Input capacitance		C _{iss}		_	1433	2150	
Reverse transfer capacitance		C _{rss}	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$	_	83	125	pF
Output capacitanc	е	C _{oss}			303	\rightarrow	
Gate resistance		Rg	V _{DS} = 10 V, V _{GS} =0 V, f = 5 MHz	-	1.0	> 1.5	Ω
Switching time	Rise time	t _r	VGS 0 V	7	3) —	
	Turn-on time	t _{on}			10	_	ns
	Fall time	t _f			3.9	_	115
	Turn-off time	t _{off}	Duty ≦ 1%, t _w ≠ 10 μs	_	23		
Total gate charge (gate-source plus gate-drain)		Qg	$V_{DD} \simeq 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 11 \text{ A}$	_	21	_	
			$V_{DD} \simeq 24 \text{ V}, V_{GS} = 5 \text{ V}, I_{D} = 11 \text{ A}$	_	11	_	
Gate-source charg	ge 1 /	Q _{ĝs1}		_	4.4	_	nC
Gate-drain ("Miller") charge		Qgd	$V_{DD} \simeq 24 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 11 \text{ A}$	_	3.7	_	
Gate switch charge	e (7)	Q _{SW}			5.0		

Source-Drain Ratings and Characteristics (Ta = 25°C)

Characteristic	Symbol Test Condition	Min	Тур.	Max	Unit
Drain reverse current Pulse (Note 1)	I _{DRP} —	_	_	44	Α
Forward voltage (diode)	V_{DSF} $I_{DR} = 11 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	-1.2	V







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